

<b>Notice of References Cited</b>	Application/Control No. 09/942,198	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Harry Vartanian	Art Unit 2634	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0085655	07-2002	Johnson, Luke A.	375/354
	B	US-2002/0091885	07-2002	Hendrickson et al.	710/100
	C	US-3,646,517	02-1972	Waters et al.	714/811
	D	US-4,461,013	07-1984	Lese et al.	375/306
	E	US-4,727,541	02-1988	Mori et al.	370/535
	F	US-4,965,797	10-1990	Yamane et al.	370/537
	G	US-6,009,107	12-1999	Arvidsson et al.	370/535
	H	US-6,335,696	01-2002	Aoyagi et al.	341/100
	I	US-6,430,242	08-2002	Buchanan et al.	375/371
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.